



**ALPHA & OMEGA**  
SEMICONDUCTOR

**AO4566**

**30V N-Channel MOSFET**

### General Description

- Latest Trench Power AlphaMOS (αMOS LV) technology
- Very Low  $R_{DS(ON)}$  at 4.5V  $V_{GS}$
- Low Gate Charge
- High Current Capability
- RoHS and Halogen-Free Compliant

### Application

- DC/DC Converters in Computing, Servers, and POL
- Isolated DC/DC Converters in Telecom and Industrial

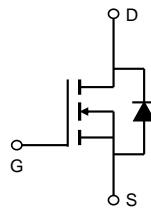
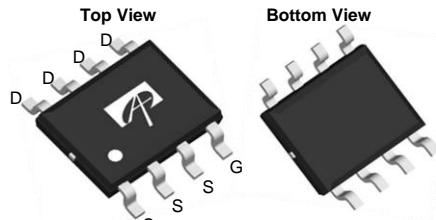
### Product Summary

|                                  |        |
|----------------------------------|--------|
| $V_{DS}$                         | 30V    |
| $I_D$ (at $V_{GS}=10V$ )         | 12A    |
| $R_{DS(ON)}$ (at $V_{GS}=10V$ )  | < 11mΩ |
| $R_{DS(ON)}$ (at $V_{GS}=4.5V$ ) | < 17mΩ |

100% UIS Tested  
100%  $R_g$  Tested



SOIC-8



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                               | Symbol         | Maximum    | Units |
|---|----------------|------------|-------|
| Drain-Source Voltage                    | $V_{DS}$       | 30         | V     |
| Gate-Source Voltage                     | $V_{GS}$       | $\pm 20$   | V     |
| Continuous Drain Current <sup>G</sup>   | $I_D$          | 12         | A     |
| $T_A=70^\circ C$                        |                | 9.4        |       |
| Pulsed Drain Current <sup>C</sup>       | $I_{DM}$       | 48         |       |
| Avalanche Current <sup>C</sup>          | $I_{AS}$       | 15         | A     |
| Avalanche energy $L=0.1mH$ <sup>C</sup> | $E_{AS}$       | 11         | mJ    |
| $V_{DS}$ Spike                          | $V_{SPIKE}$    | 36         | V     |
| $T_A=25^\circ C$                        | $P_D$          | 2.5        | W     |
| $T_A=70^\circ C$                        |                | 1.6        |       |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$ | -55 to 150 | °C    |

### Thermal Characteristics

| Parameter  | Symbol          | Typ | Max | Units |
|--|-----------------|-----|-----|-------|
| Maximum Junction-to-Ambient <sup>A</sup><br>$t \leq 10s$   | $R_{\theta JA}$ | 42  | 50  | °C/W  |
| Maximum Junction-to-Ambient <sup>A,D</sup><br>Steady-State |                 | 70  | 85  | °C/W  |
| Maximum Junction-to-Lead                                   | $R_{\theta JL}$ | 20  | 30  | °C/W  |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min | Typ  | Max       | Units            |
|-----------------------------|---------------------------------------|--|-----|------|-----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |      |           |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$   | 30  |      |           | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=30\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                |     |      | 1<br>5    | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$                                      |     |      | $\pm 100$ | nA               |
| $V_{GS(\text{th})}$         | Gate Threshold Voltage                | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$  | 1.3 | 1.8  | 2.3       | V                |
| $R_{DS(\text{ON})}$         | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}, I_D=12\text{A}$  |     | 9    | 11        | $\text{m}\Omega$ |
|                             |                                       | $T_J=125^\circ\text{C}$  |     | 12.5 | 15        |                  |
|                             |                                       | $V_{GS}=4.5\text{V}, I_D=10\text{A}$   |     | 13.5 | 17        |                  |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=5\text{V}, I_D=12\text{A}$   |     | 45   |           | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=1\text{A}, V_{GS}=0\text{V}$  |     | 0.72 | 1         | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |      | 3.5       | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |      |           |                  |
| $C_{iss}$                   | Input Capacitance                     | $V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$                           |     | 542  |           | pF               |
| $C_{oss}$                   | Output Capacitance                    |  |     | 233  |           | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |  |     | 31   |           | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$                            | 1   | 2    | 3         | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |      |           |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=12\text{A}$                         |     | 9    | 12.2      | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |  |     | 4.3  | 5.8       | nC               |
| $Q_{gs}$                    | Gate Source Charge                    |  |     | 2.2  |           | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |  |     | 1.7  |           | nC               |
| $t_{D(\text{on})}$          | Turn-On Delay Time                    | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=1.25\Omega, R_{\text{GEN}}=3\Omega$ |     | 4    |           | ns               |
| $t_r$                       | Turn-On Rise Time                     |  |     | 3.5  |           | ns               |
| $t_{D(\text{off})}$         | Turn-Off Delay Time                   |  |     | 18   |           | ns               |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 3    |           | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=12\text{A}, dI/dt=500\text{A}/\mu\text{s}$                                |     | 9.7  |           | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=12\text{A}, dI/dt=500\text{A}/\mu\text{s}$                                |     | 11.5 |           | nC               |

A. The value of  $R_{iJA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using  $\leq 10\text{s}$  junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ . Ratings are based on low frequency and duty cycles to keep initial  $T_J=25^\circ\text{C}$ .

D. The  $R_{iJA}$  is the sum of the thermal impedance from junction to lead  $R_{iUL}$  and lead to ambient.

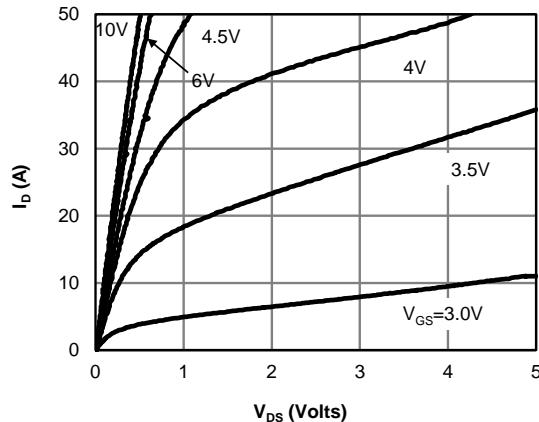
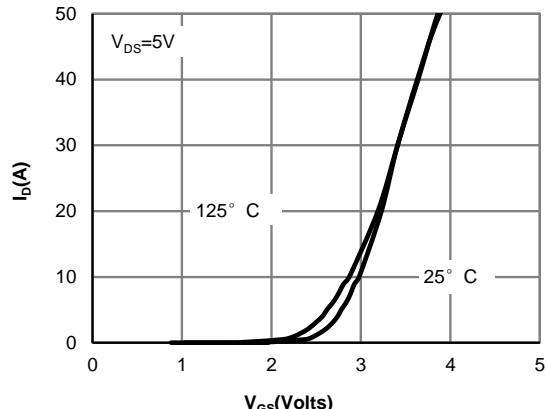
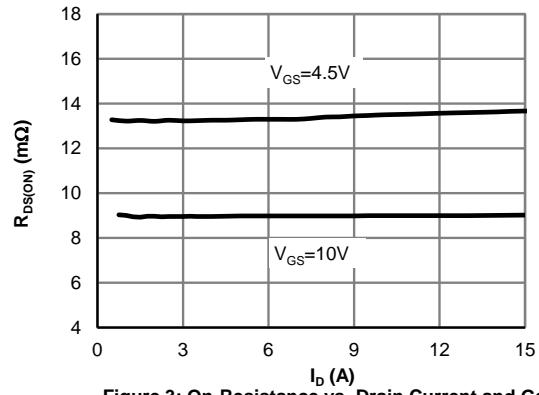
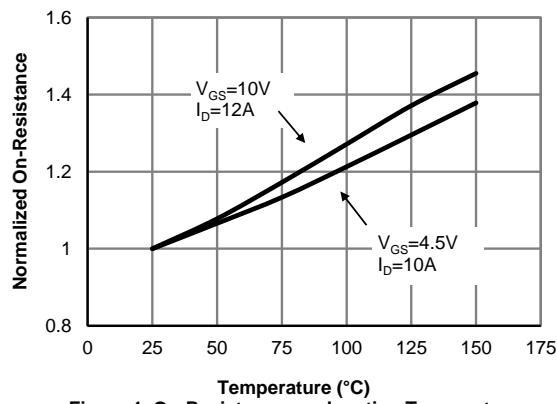
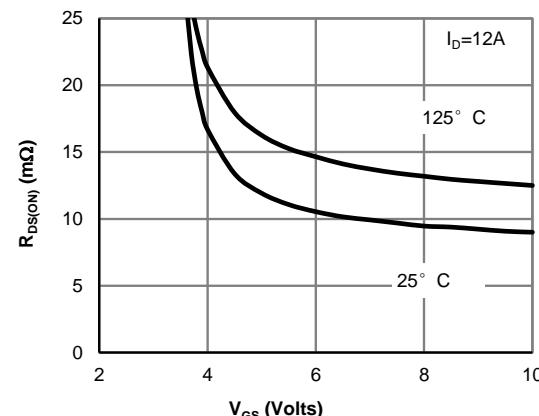
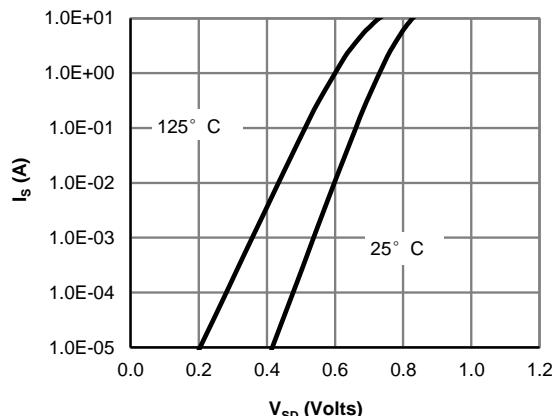
E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.

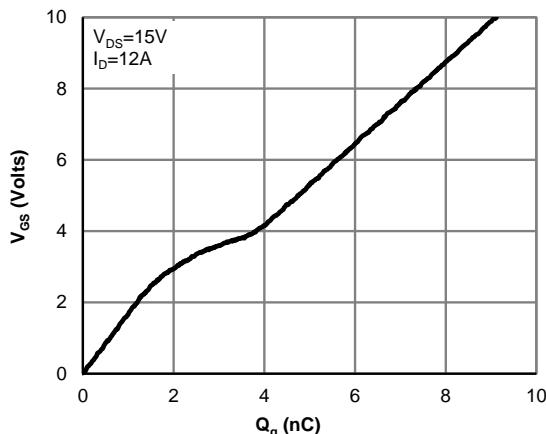
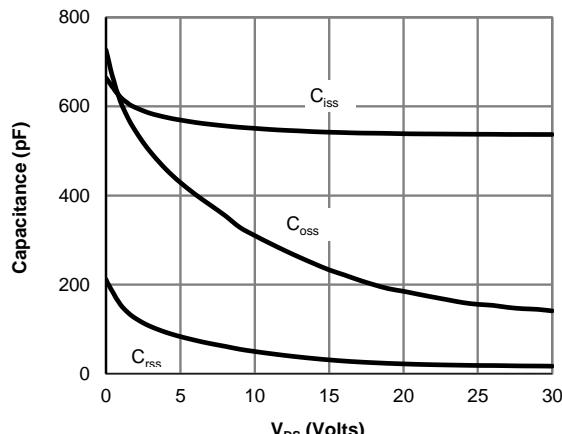
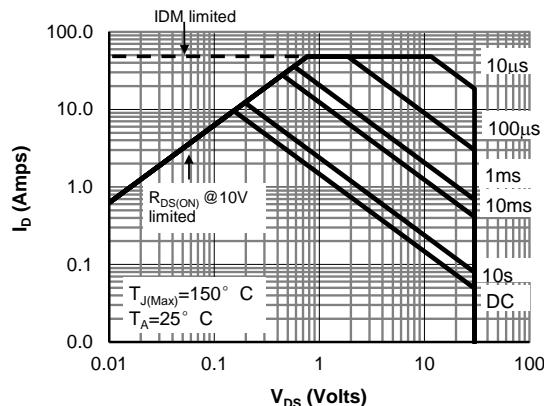
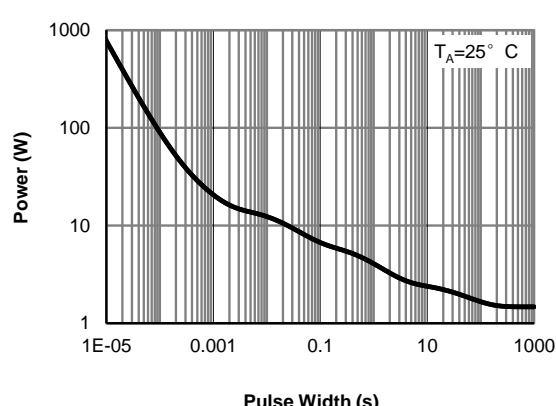
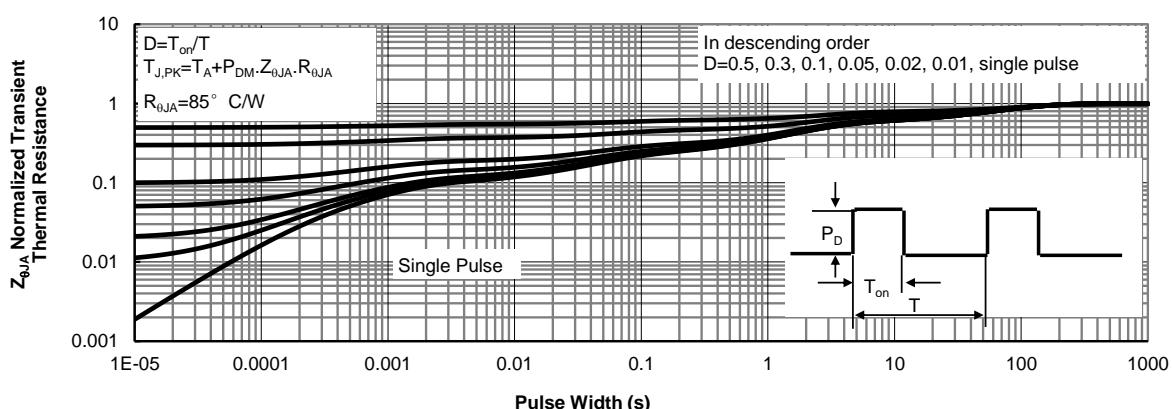
F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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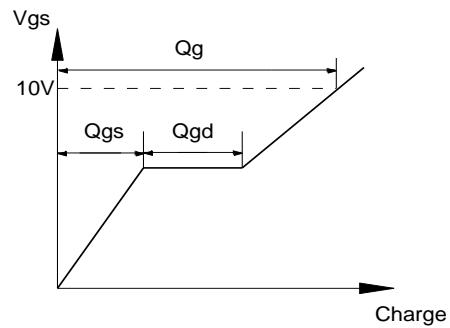
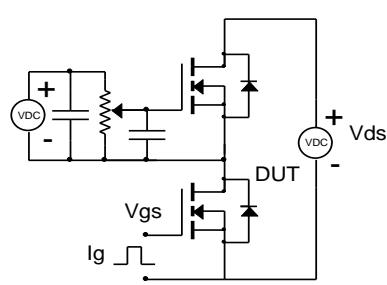
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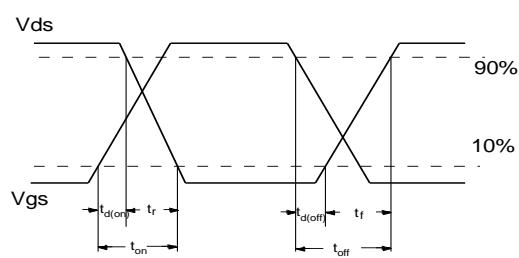
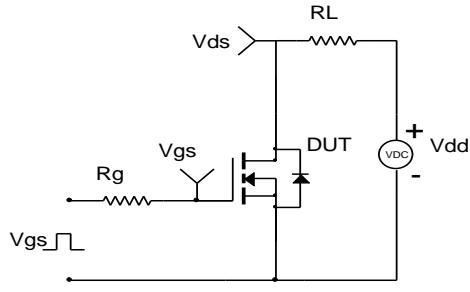
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Fig 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**

**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**

**Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)**

**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

